

# **NEW MEASUREMENTS OF X-RAY** FUNDAMENTAL PARAMETERS



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X-ray fundamental parameters are of the utmost importance for quantitative and qualitative X-ray based techniques. In reference-free methods, the quality of the analysis result is directly dependent on the reliability of such parameters characterizing the interaction between X-ray photons and matter:  $\mu$ ,  $\omega$ , f. New values of these parameters can be obtained either by experimental work, using modern facilities, or through quantum mechanical calculations.





## The mass attenuation coefficients $(\mu/\rho)$

Several databases exist and some of them are accessible to the community: Berger<sup>a</sup> (available online (NIST-XCOM) or xraylib), Henke<sup>b</sup> (available online (CXRO)), Elam<sup>c</sup>, Ebel<sup>d</sup>, Cullen<sup>e</sup>. Unfortunately, <u>large</u>

### The fluorescence yields $(\omega)$

Estimated percentage uncertainties for fluorescence and Coster-Kronig vields

The available databases contain only limited experimental results, together with theoretical calculations. Nonetheless, discrepancies exist between tables: see example between Bambynek<sup>f</sup>, Krause<sup>g</sup> and Hubbell<sup>h</sup>

M. Krause et al., "X-ray fluorescence cross sections for K and L X-rays of the elements", Oak Ridge National Laboratory, Report No.: ORNL-5399 (1978)

<u>uncertainties are reported</u>.

[a] M.J. Berger et al., XCOM: Photon Cross Sections Database. Available online: http://physics.nist.gov/PhysRefData/Xcom/Text/XCOM.html

[b] B.L. Henke et al., photoabsorption, scattering, transmission, and reflection at E=50-30000 eV, Z=1-92, Atomic Data and Nuclear Data Tables Vol. 54 (2), 181-342 (1993). Available online: http://henke.lbl.gov/optical\_constants/

[c] W.T. Elam et al., A new atomic database for X-ray spectroscopic calculations, Radiation Physics and Chemistry, Vol. 63, pp. 121128, 2002

[d] H. Ebel et al., Numerical description of photoelectric absorption coefficients for fundamental parameters programs, X-Ray Spectrometry, vol. 32, no. 6, pp. 442451, 2003

[e] Dermott E. Cullen, UCRL--50400, Vol. 6, Rev. 5; "EPDL97: the Evaluated Photon Data Library".

| Z (range) | ω <sub>κ</sub> | $\omega_{L1}$ | $\omega_{L2}$ | $\omega_{L3}$ | f <sub>12</sub> | f <sub>13</sub> | f <sub>23</sub> | 1.05 -     |   |
|-----------|----------------|---------------|---------------|---------------|-----------------|-----------------|-----------------|------------|---|
| 5-10      | 40-10          |               |               |               |                 |                 |                 |            |   |
| 10-20     | 10-5           | >30           | >25           | >25           | 10              | 5               |                 | ຊັ້ 1.00 − |   |
| 20-30     | 5-3            | 30            | 25            | 25            | 15              | 10              | 40              |            | • |
| 30-40     | 3              | 30            | 25            | 20            | 15              | 10              | 30-20           |            |   |
| 40-50     | 2              | 30-20         | 25-10         | 20-10         | 20              | 10              | 20              | ng 0.95 -  |   |
| 50-60     | 2-1            | 20-15         | 10            | 10-5          | 20              | 15              | 20              | • •        |   |
| 60-70     | 1              | 15            | 10-5          | 5             | 15              | 10              | 20-15           | ·          |   |
| 70-80     | 1              | 15            | 5             | 5-3           | 20              | 10-5            | 15              | • • • •    |   |
| 80-90     | <1             | 15            | 5             | 3             | 10              | 5               | 15              | •          |   |
| 90-100    | <1             | 15-20         | 10            | 3-5           | 10-50           | 5-10            | 15              | •          |   |
| 100-110   | 1              | 20            | 10            | 5             | 50-100          | 15              | 20              | 0.00 -     |   |

[f] W. Bambynek et al., Review of Modern Physics, Vol. 44 (1972)

[g] M.O. Krause, J. Phys. Chem. Ref. Data., Vol. 8 (1979)



Hubbell vs Bambynek

• Krause *vs* bambynek

## MEASUREMENT OF THE MASS ATTENUATION COEFFICIENTS OF Cu (LNHB & PTB)

Transmission measurement of thin samples: the Beer-Lambert law links the transmission to the total mass attenuation coefficient  $\frac{\mu}{\rho} = -\frac{A}{M} \times \ln\left(\frac{I - I_{bruit}}{I_0 - I_{total}}\right) \times k_p$ 

- $\rightarrow$  independent measurement of the sample mass (M) and area (A) is needed
- $\rightarrow$  evaluation of the bias introduced by possible elemental impurities  $(k_p)$
- $\rightarrow$  special care was taken to characterize the photon beam (stability, monochromaticity, size)
- $\rightarrow$  careful evaluation of the combined standard uncertainty budget





## DETERMINATION OF $\mu$ , $\tau$ , $\omega$ , and f OF Sn

- 1.  $\mu$  are measured by a transmission setup using samples of different thicknesses in the 0.1-35 keV energy range
- 2. Partial attenuation coefficients due to the L subshells are derived from  $\mu$
- 3. Fluorescence spectra are recorded as the excitation photon energy is progressively increased across each partial L transition edge



4.  $\omega \times \tau$  are derived from fluorescence spectra using Sherman's

### equations

5. A fitting procedure is used to take into account the electron correlation effect on the photoabsorption coefficient ( $\tau$ ) near the transition energies, starting with the  $L_3$  subshell to derive  $\omega_3$  and  $\tau_3$ , which are then used to derive  $f_{23}$  with an excitation energy above  $L_2 \dots$ 





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